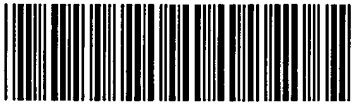


Search Notes

Application/Control No.

08/726,613

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

MORI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	7/2006	JSC
430	905		
430	910		
430	926		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	270.1,905	7/2006	JSC
430	910,926		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	7/2006	JSC
Sturcture search done by EIC 1700		